

LIST OF ART CITED BY APPLICANT

DEC 07 2005

PTO-1449)

ATTY. DOCKET NO.
P-0588APPLN. SERIAL NO.
10/696,997

APPLICANT(S)

Jae-Cheol LEE

FILING DATE
October 31, 2003GROUP
2631

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
SL	WO 01/74103 A1	20/04/2001	WIPO (English Abstract & Chinese Full Text)	—	—	X	
SL	JP 2002-246955	08/30/2002	Japan (English Abstract & Japanese Full Text)	—	—	X	
SL	JP 04-053324	02/20/1992	Japan (English Abstract & Japanese Full Text)	—	—	X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

SL	3 rd Generation Partnership Project; Technical Specification Group Radio Access Network; Spreading and Modulation (TDD) (Release 4) – 3GPP TS 25.223 V4.4.0 (2002-03)
SL	CWTS, "Frame Structure for Low Chip Rate TDD Option." TSG-RAN Working Group 1, Meeting 12, TSGR1 (00)0491, Seoul, Korea, April 10-13, 2000.
SL	Copy of Japanese Office Action.

EXAMINER

/Siu Lee/


DATE CONSIDERED

01/12/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

\\fk4\Documents\2000\2000-688\81665.doc

LIST OF ART CITED BY APPLICANT (PTO-1449)				ATTY. DOCKET NO. P-0588		APPLN. SERIAL NO. 10/696,997	
				APPLICANT(S) Jae-Cheol LEE			
				FILING DATE October 31, 2003		GROUP 2631	



U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS						
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS						
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
SL	CN 1311566	09/05/2001	China (Full Text & English Abstract)	—	—	X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)	
SL	Chinese Office Action (English) dated June 10, 2005

EXAMINER /Siu Lee/	DATE CONSIDERED 01/12/2007
-----------------------	-------------------------------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)				ATTY. DOCKET NO. P-0588		APPLN. SERIAL NO. 10/696,997	
				APPLICANT(S) Jae-Chool LEE			
				FILING DATE 10/31/2003		GROUP 2631	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
U.S. PATENT APPLICATION PUBLICATIONS							
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS		
U.S. PATENT APPLICATIONS							
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS		
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
SL	0 372 759 A2	6/13/90	EPO	—	—		
SL	WO03/039043 A1	5/8/03	WIPO	—	—		

LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)	
OTHER ART (including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)	
SL	European Patent Office Search Report dated 1/19/04
EXAMINER	/Siu Lee/
DATE CONSIDERED	01/12/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.